



N-channel Enhancement Mode Power MOSFET

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FEATURES

♦ 100V, 220A

 $R_{DS(ON)} < 1.45 \text{m}\Omega$ @ VGS = 10V

- ◆ Ultra-low R_{DS(ON)}
- ◆ Low Gate Charge
- ◆ Lead Free

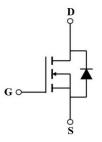


- ◆ Motor Driving in Power Tool, E-vehicle, Robotics
- ◆ Current Switching in DC/DC & AC/DC
- ◆ Power Management









TOLL-8

Marking and Pin Assignment

Schematic Diagram

PACKAGE MARKING AND ORDERING INFORMATION

OPN	Marking	Package	Quantity	
BRP100N220P6	P100N220	TOLL-8	2000pcs/Reel	

ABSOLUTE MAXIMUM RATINGS

Symbol	Defin	lition	Ratings	Unit
V_{DS}	Drain-to-Sou	100	V	
V_{GS}	Gate-to-Source Voltage		±20	V
T_	Continuous Drain Current	$T_{\rm C} = 25^{\circ}{ m C}$	220	A
I_D		$T_C = 100$ °C	146	A
I_{DM}	Pulsed Drain	n Current (1)	880	A
E _{AS}	Single Pulsed Ava	648	mJ	
P _D	Power Dissipat	ion, $T_C = 25^{\circ}C$	500	W
$R_{ heta JC}$	Thermal Resistance	e, Junction to Case	0.25	°C/W
T _J , T _{STG}	Junction & Storage	Temperature Range	-55 ∼ +150	°C



ELECTRICAL CHARACTERISTICS (All test condition is T_J=25°C, unless otherwise noted)

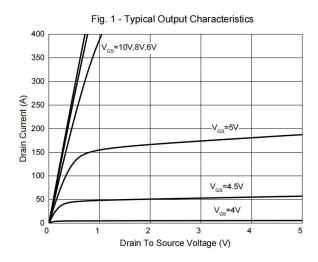
Symbol	Parameter	Condition	Min	Тур	Max	Unit
Off Characte	eristics					
V _{(BR)DSS}	Drain-Source Breakdown Voltage	$I_D = 250 \mu A, V_{GS} = 0 V$	100	-	-	V
I_{DSS}	Zero Gate Voltage Drain Current	$V_{DS}=80V,V_{GS}=0V$	-	-	1	uA
I_{GSS}	Gate-Body Leakage Current	$V_{DS} = 0V, V_{GS} = \pm 20V$	-	-	±100	nA
On Characte	ristics		1	1		
V _{GS(TH)}	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_D = 250uA$	2.0	3.0	4.0	V
R _{DS(ON)}	Static Drain-Source ON-Resistance ⁽³⁾	$V_{GS} = 10V, I_D = 30A$	-	1.2	1.45	mΩ
Dynamic Ch	aracteristics		ı			ı
Ciss	Input Capacitance		-	13258	-	pF
Coss	Output Capacitance	$V_{GS} = 0V, V_{DS} = 50V,$ f = 1MHz	-	2058	-	pF
C _{rss}	Reverse Transfer Capacitance		-	111	-	pF
R_g	Gate Resistance	$V_{GS} = 0V, V_{DS} = 0V,$ f = 1MHz	-	3.6	-	Ω
Qg	Total Gate Charge		-	240	-	nC
Q_{gs}	Gate Source Charge	$V_{GS} = 0$ to $10V$ $V_{DS} = 50V$, $I_D = 30A$	-	60	-	nC
Q_{gd}	Gate Drain("Miller") Charge	25 , 2	-	59	-	nC
Switching Cl	naracteristics	1	1	1	ı	1
t _{d(on)}	Turn-On Delay Time		-	33	-	ns
t _r	Turn-On Rise Time	$V_{GS} = 10V, V_{DS} = 50V$	-	69	-	ns
$t_{d(off)}$	Turn-Off Delay Time	$I_D = 30A, R_{GEN} = 4.5\Omega$	-	172	-	ns
t_{f}	Turn-Off Fall Time	-	105	-	ns	
Drain-Source	e Diode Characteristics					
Is	Continuous Source Current		-	-	220	A
V_{SD}	Forward on voltage	$V_{GS}=0V,I_S=30A$	-	-	1.3	V
Trr	Reverse Recovery Time	I 204 17/1 1004/	-	124	-	ns
Qrr	Reverse Recovery Charge	$I_F = 30A$, $di/dt = 100A/us$	-	388	-	nC

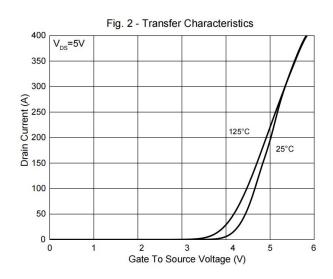
Notes:

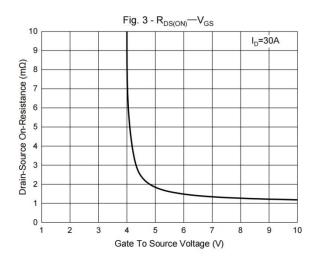
- 1. Repetitive Rating: Pulse Width Limited by Maximum Junction Temperature.
- 2. E_{AS} condition: Starting T_J =25°C, V_{DD} =50V, V_G =10V, L=0.5mH, I_{AS} =50A
- 3. Pulse Test: Pulse Width $\leq 300 \mu s$, Duty Cycle $\leq 0.5\%$.

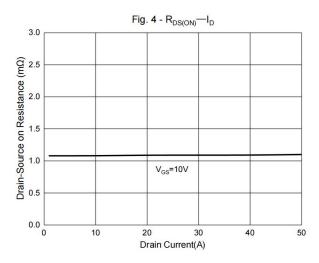


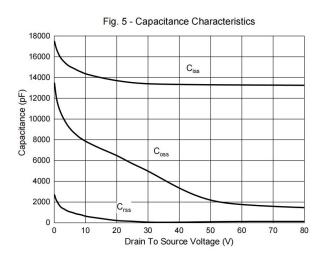
TYPICAL PERFORMANCE CHARACTERISTICS

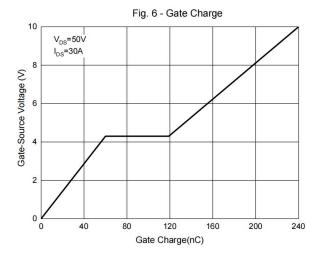






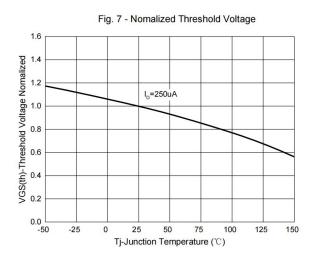


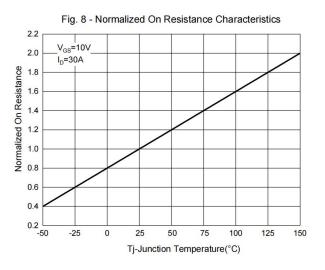


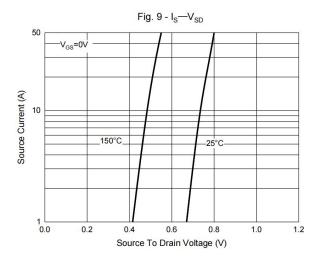


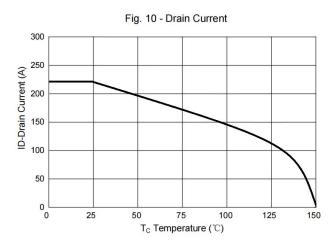


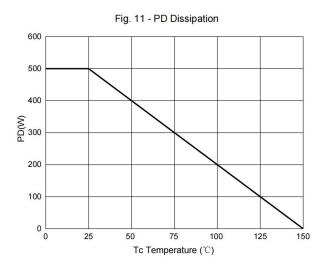
TYPICAL PERFORMANCE CHARACTERISTICS

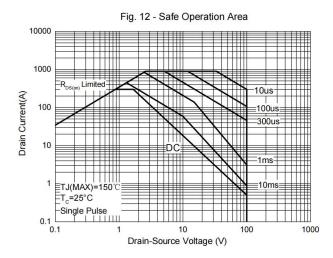






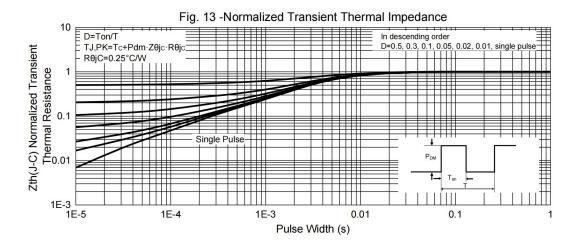








TYPICAL PERFORMANCE CHARACTERISTICS





TEST CIRCUIT

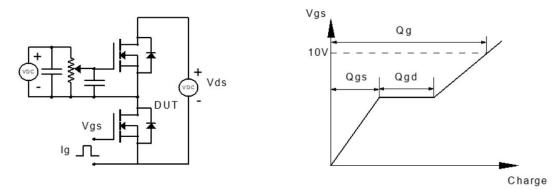


Figure 14: Gate Charge Test Circuit & Waveform

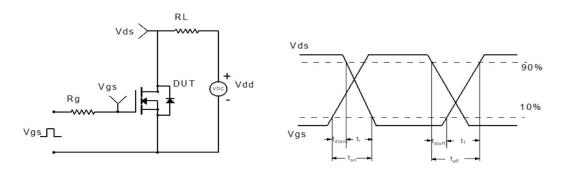


Figure 15: Resistive Switching Test Circuit & Waveform

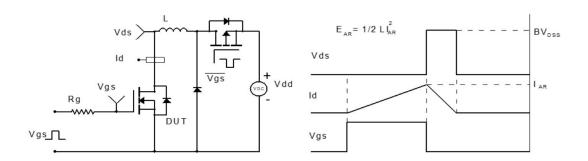


Figure 16: Unclamped Inductive Switching Test Circuit & Waveform

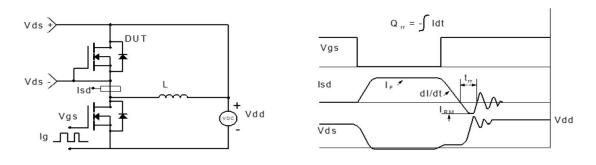
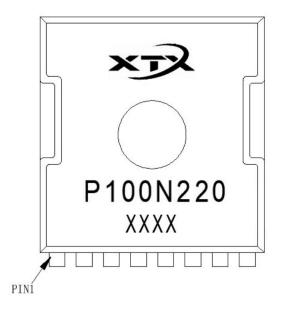


Figure 17: Diode Recovery Test Circuit & Waveform



MARKING INFORMATION



1st Line: XTX Logo

2nd Line: Part Number (P100N220)

3rd Line: Date Code (XXXX)

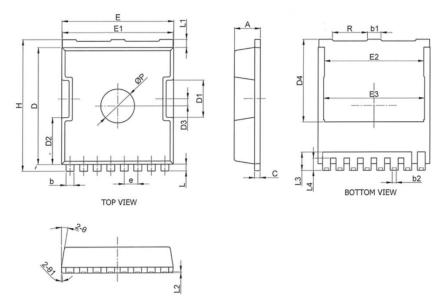
XX: Year

XX: Week (01 to 53)

Year	2021	2022	2023	2024	2025	2026	2027	2028	2029	2030	2031	2032	2033
Code	21	22	23	24	25	26	27	28	29	30	31	32	33



DETAIL PACKAGE OUTLINE DRAWING (TOLL-8)



CVALDOL	MILLIMETERS						
SYMBOL	MIN	NOM	MAX				
A	2.20	2.30	2.40				
b	0.60	0.70	0.80				
b1	1.10	1.20	1.30				
b2	0.26	0.36	0.51				
С	0.40	0.50	0.60				
D	10.30	10.40	10.50				
D1	3.20	3.30	3.40				
D2	4.08	4.18	4.28				
D3	0.53	0.63	0.73				
D4	7.25	7.35	7.50				
Е	9.80	9.90	10.00				
E1	9.70	9.80	9.90				
E2	8.70	8.80	8.90				
E3	8.85	8.95	9.05				
e	1.20 BSC						
Н	11.50	11.50 11.70 1					
L	0.50	0.60	0.70				
L1	0.60	0.70	0.80				
L2	0.05	0.10	0.20				
L3	1.45	1.65	1.85				
L4	0.90	1.10	1.30				
P	2.00	3.00	4.00				
R	3.00	3.10	3.20				
θ	7°	9°	11°				
θ1	3°	5°	7°				



REVISION HISTORY

Number	Description
Rev 1.0	BRP100N220P6 datasheet release